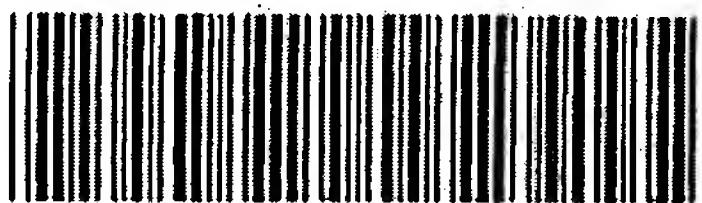


## **Search Notes**



**Application/Control No.**

10/784.719

**Examiner**

**Susanna M. Diaz**

**Applicant(s)/Patent under  
Reexamination**

SCHOEN ET AL

## Art Unit

3694

SEARCHED

# **SEARCH NOTES (INCLUDING SEARCH STRATEGY)**

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner